

Notice of References Cited	Application/Control No. 10/552,439		Applicant(s)/Patent Under Reexamination ASADA ET AL.	
	Examiner CHIA-WEI A. CHEN		Art Unit 2622	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0146981	08-2003	Bean et al.	348/222.1
*	B	US-2004/0033051	02-2004	IP, Kiril Kun Wan	386/35
*	C	US-7,394,484	07-2008	Soya et al.	348/208.16
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	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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